

## 68V N-Channel Power MOSFET

### DESCRIPTION

The JRM08N68 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge. It can be used in a wide variety of applications.

### Application

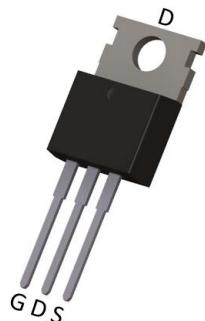
- Power switching application
- Hard switched and High frequency circuits
- Uninterruptible power supply

### KEY CHARACTERISTICS

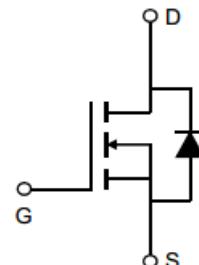
- $V_{DS} = 68V, I_D = 90A$
- $R_{DS(ON)} < 7.5m\Omega @ V_{GS}=10V$
- Special process technology for high ESD capability
- High density cell design for ultra low  $R_{DS(on)}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high EAS
- Excellent package for good heat dissipation

**100% UIS TESTED!**

**100% DVDS TESTED!**



TO-220 Top View



Schematic diagram

### Package Marking And Ordering Information

Device Marking	Ordering Codes	Package	Product Code	Packing
M08N68	JRM08N68-P	TO-220	JRM08N68	Tube

### Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	68	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$	90	A
Drain Current-Pulsed (Note 1)	$I_{DM}$	320	A
Maximum Power Dissipation( $T_c=25^\circ C$ )	$P_D$	125	W
Single pulse avalanche energy (Note 2)	$E_{AS}$	370	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 175	°C

### Thermal Characteristic

Thermal Resistance,Junction-to-Case	$R_{\theta JC}$	1.2	°C/W
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**Electrical Characteristics (TA=25°C unless otherwise noted)**

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	68	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =68V, V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	-	-	±100	nA
<b>On Characteristics</b>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2	3	4	V
Drain-Source On-State Resistance <sup>(Note 3)</sup>	R <sub>D(S)ON</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =45A	-	6.5	7.5	mΩ
Forward Transconductance	G <sub>FS</sub>	V <sub>DS</sub> =10V, I <sub>D</sub> =20A	-	20	-	S
<b>Dynamic Characteristics</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, F=1.0MHz	-	3200	-	pF
Output Capacitance	C <sub>oss</sub>		-	440	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	180	-	pF
<b>Switching Characteristics</b> <sup>(Note 4)</sup>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =30V, ID=30A, V <sub>GS</sub> =10V, R <sub>GEN</sub> =6Ω	-	16	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	95	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	47	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	31	-	nS
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =30V, I <sub>D</sub> =20A V <sub>GS</sub> =10V	-	40	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	11	-	nC
Gate-Drain Charge	Q <sub>gd</sub>		-	15	-	nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage <sup>(Note 3)</sup>	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =90A	-	-	1.2	V

**Notes:**

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. E<sub>AS</sub> condition :T<sub>j</sub>=25°C, V<sub>DD</sub>=30V, V<sub>G</sub>=10V, L=0.5mH, R<sub>G</sub>=25Ω
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production.

### Characteristics Curves

Figure 1 Output Characteristics

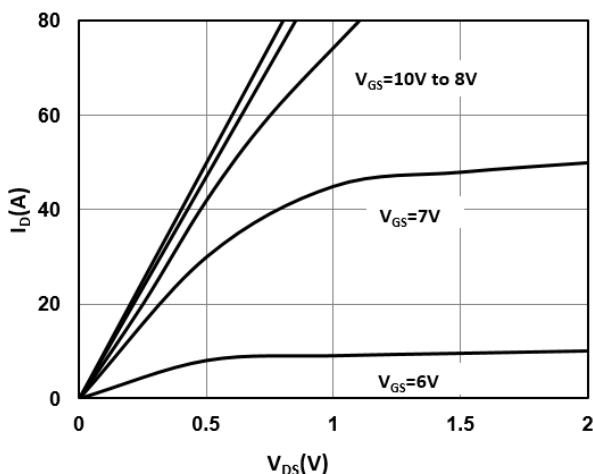


Figure 2 Transfer Characteristics

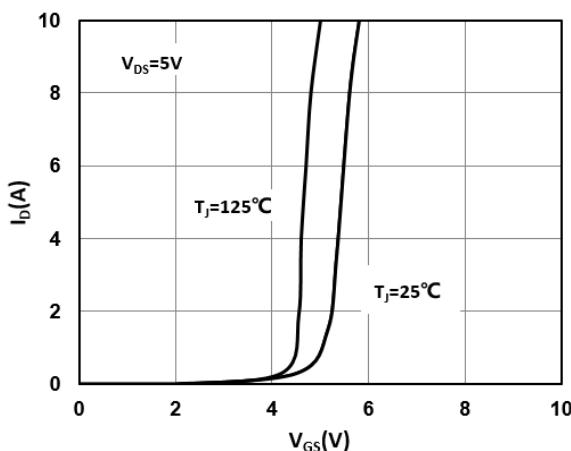


Figure 3 On-Resistance vs.  $I_D$  and  $V_{GS}$

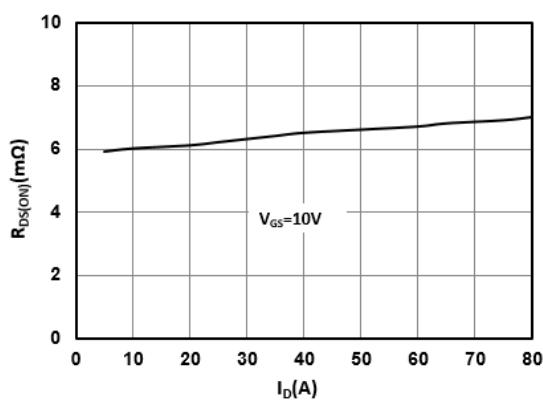


Figure 4 On-Resistance vs. Junction Temperature

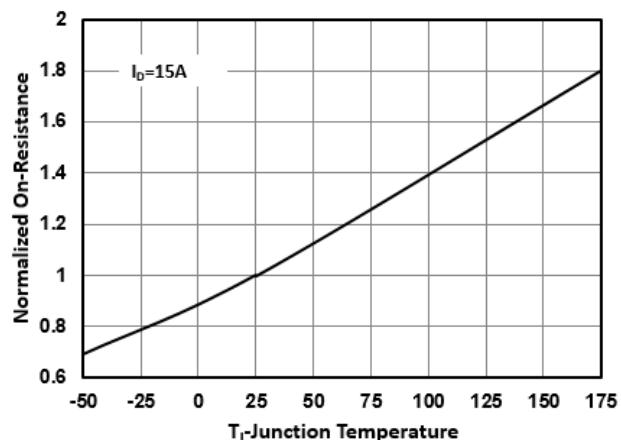


Figure 5 On-Resistance vs.  $V_{GS}$

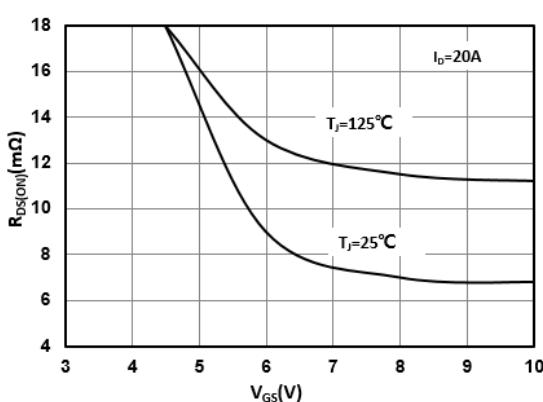


Figure 6 Body Diode Forward Voltage

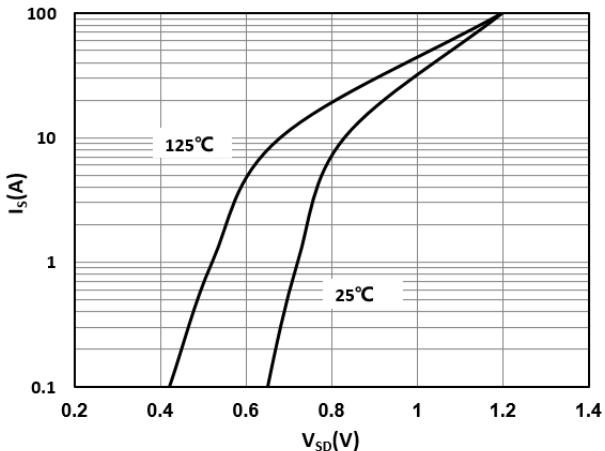


Figure 7 Gate-Charge Characteristics

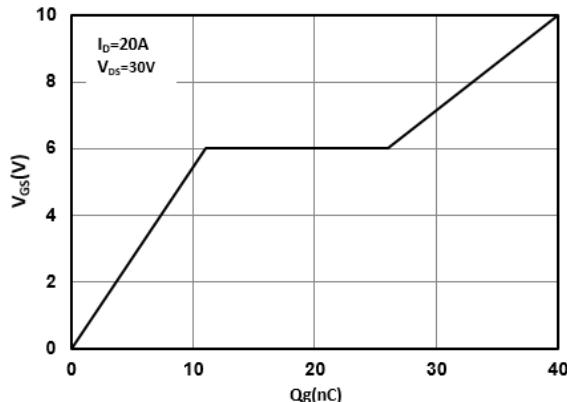


Figure 8 Capacitance Characteristics

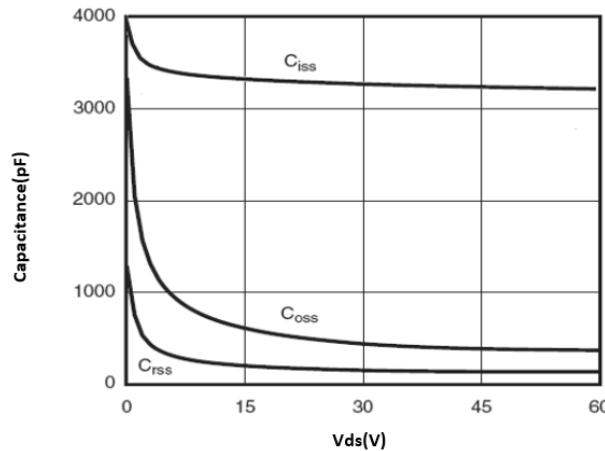


Figure 9 Maximum Forward Biased Safe Operation Area

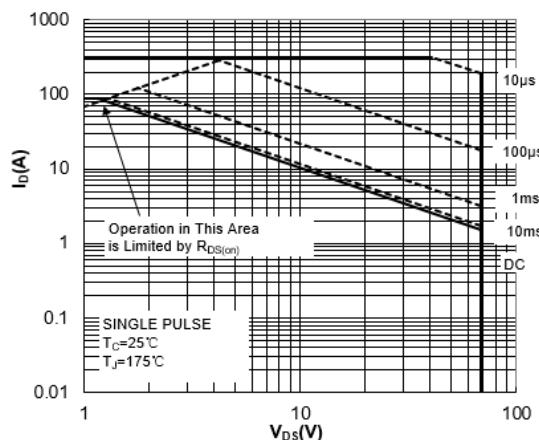


Figure 10 Single Pulse Power Rating Junction-to-Ambient

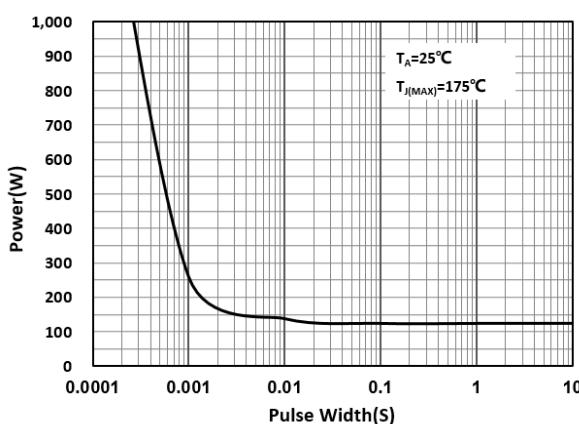
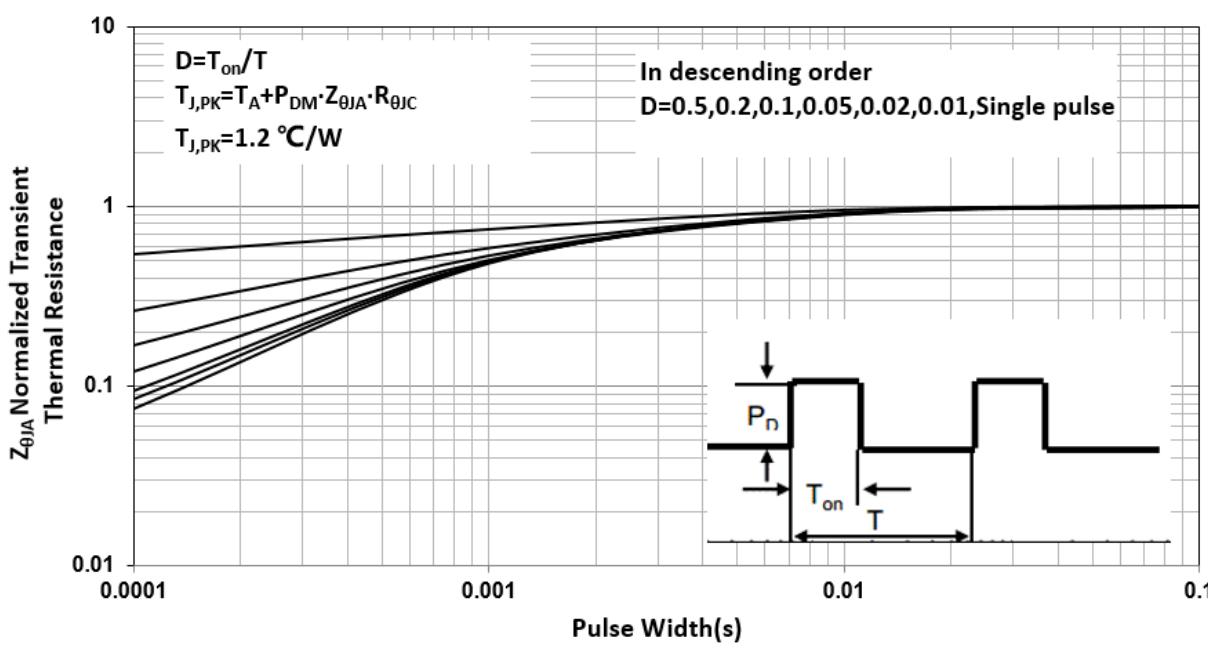
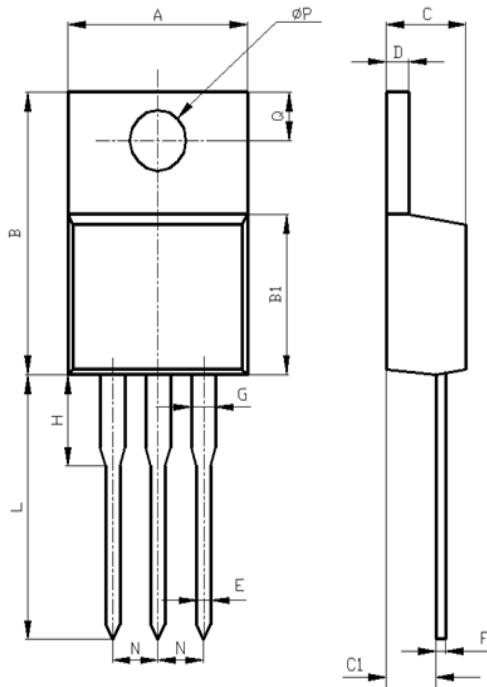


Figure 11 Normalized Maximum Transient Thermal Impedance



## Package Description



Items	Values(mm)	
	MIN	MAX
A	9.60	10.6
B	15.0	16.0
B1	8.90	9.50
C	4.30	4.80
C1	2.30	3.10
D	1.20	1.40
E	0.70	0.90
F	0.30	0.60
G	1.17	1.37
H	2.70	3.80
L	12.6	14.8
N	2.34	2.74
Q	2.40	3.00
$\phi P$	3.50	3.90

TO-220 Package

**NOTE:**

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shanghai Jerrett reserves the right to make changes in this specification sheet and is subject to change without prior notice.